

## DESCRIPTION

The MXB6888 is N-channel MOS Field Effect Transistor designed for high current switching applications. Rugged E<sub>AS</sub> capability and ultra low R<sub>DS(ON)</sub> is suitable for PWM, load switching especially for E-Bike controller applications.

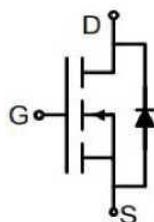
## GENERAL FEATURES

- V<sub>DS</sub>=68V, I<sub>D</sub>=80A @ V<sub>GS</sub>=10V  
R<sub>DS(ON)</sub>(Typ.)=6.8mΩ @ V<sub>GS</sub>=10V
- Special Designed for E-Bike Controller Application
- Ultra Low On-Resistance
- High UIS and UIS 100% Test

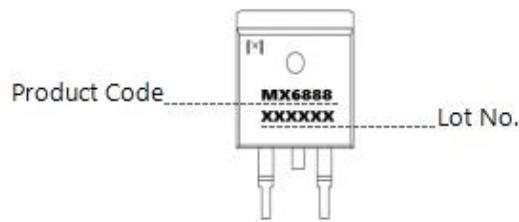
## APPLICATION

- 48V E-Bike Controller Applications
- Hard Switched and High Frequency Circuits
- Uninterruptible Power Supply

## PINOUT



Schematic diagram



Marking and pin Assignment



TO-263 top view

## PACKAGE INFORMATION

Package	Storage Temperature	Package	Devices Per Reel
MXB6888	-55°C to 175°C	TO-263	-

## ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage (V <sub>GS</sub> =0V)	V <sub>DS</sub>	68	V
Gate-Source Voltage (V <sub>DS</sub> =0V)	V <sub>GS</sub>	±20	V
Drain Current (DC) at T <sub>C</sub> =25°C	I <sub>D(DC)</sub>	80	A
Drain Current (DC) at T <sub>C</sub> =100°C	I <sub>D(DC)</sub>	45	A
Drain Current-Continuous@ Current-Pulsed (Note1)	I <sub>DM(pluse)</sub>	260	A
Peak Diode Recovery Voltage	dV/dt	8	V/ns
Maximum Power Dissipation(T <sub>C</sub> =25°C)	P <sub>D</sub>	75	W
Derating Factor		0.5	W/°C
Single Pulse Avalanche Energy (Note 2)	E <sub>AS</sub>	300	mJ
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C

## THERMAL RESISTANCE

Parameter	Symbol	Max.	Unit
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	2.34	°C/W

Note 1. Repetitive Rating: Pulse width limited by maximum junction temperature

Note 2. E<sub>AS</sub> condition: T<sub>J</sub>=25°C, V<sub>DD</sub>=33V, V<sub>G</sub>=10V


**ELECTRICAL CHARACTERISTICS**( $T_A=25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>On/Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	68	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=64\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm100$	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2	-	4	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=40\text{A}$	-	6.8	8.2	$\text{m}\Omega$

**Dynamic Characteristics**

Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=15\text{A}$	15	-	-	S
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	2873	-	pF
Output Capacitance	$C_{\text{oss}}$		-	252	-	pF
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	205	-	pF
Total Gate Charge	$Q_g$	$V_{\text{DS}}=50\text{V}, I_{\text{D}}=40\text{A}, V_{\text{GS}}=10\text{V}$	-	56	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	10	-	nC
Gate-Drain Charge	$Q_{\text{gd}}$		-	16	-	nC

**Switching Characteristics**

Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=30\text{V}, I_{\text{D}}=2\text{A}, R_{\text{L}}=15\Omega, V_{\text{GS}}=10\text{V}, R_{\text{GEN}}=2.5\Omega$	-	14.5	-	nS
Turn-on Rise Time	$t_r$		-	24	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	45	-	nS
Turn-Off Fall Time	$t_f$		-	22	-	nS

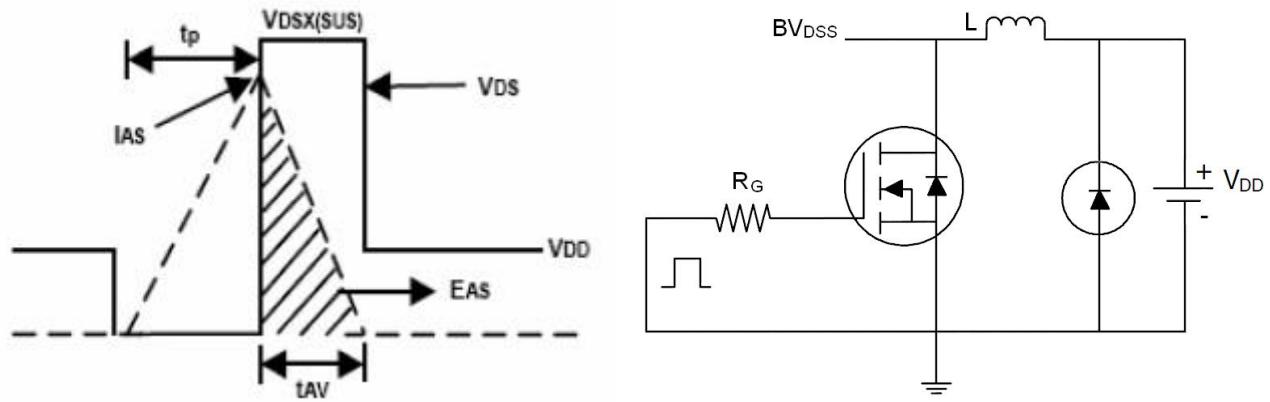
**Source-Drain Diode Characteristics**

Forward On Voltage <sup>(Note1)</sup>	$V_{\text{SD}}$	$T_J=25^\circ\text{C}, V_{\text{GS}}=0\text{V}, I_{\text{S}}=40\text{A}$	-	0.89	0.99	V
Source-Drain Current(Body Diode)	$I_{\text{SD}}$		-	65	-	A
Pulsed Source-Drain Current(Body Diode)			-	260	-	A
Reverse Recovery Time <sup>(Note1)</sup>	$t_{\text{rr}}$	$T_J=25^\circ\text{C}, I_{\text{F}}=75\text{A}, \frac{di}{dt}=100\text{A}/\mu\text{s}$	-	22	-	nS
Reverse Recovery Charge <sup>(Note1)</sup>	$Q_{\text{rr}}$		-	27	-	nC
Forward Turn-On Time	$t_{\text{on}}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_s+L_D$ )				

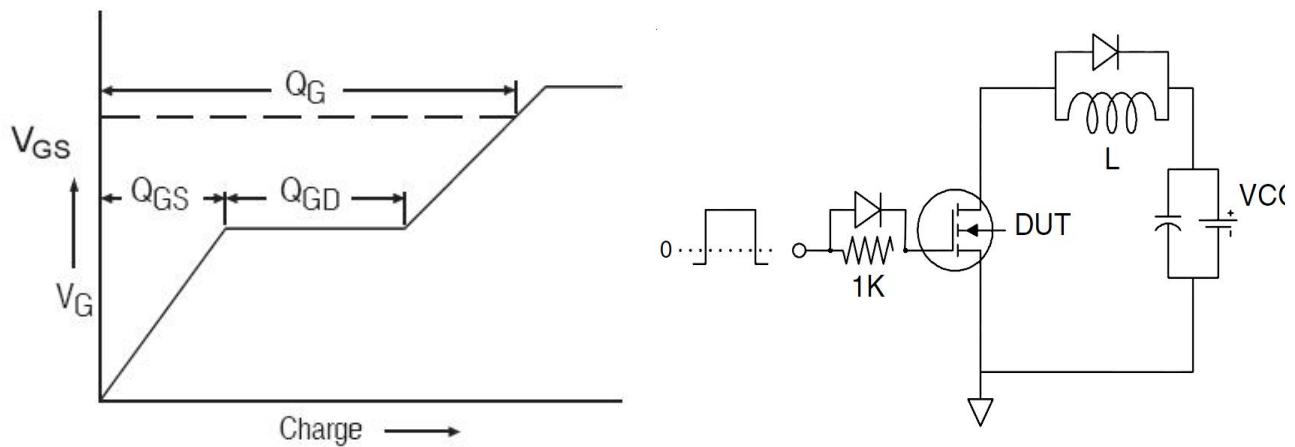
Notes 1. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 1.5\%$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$

## TYPICAL PERFORMANCE CHARACTERISTICS

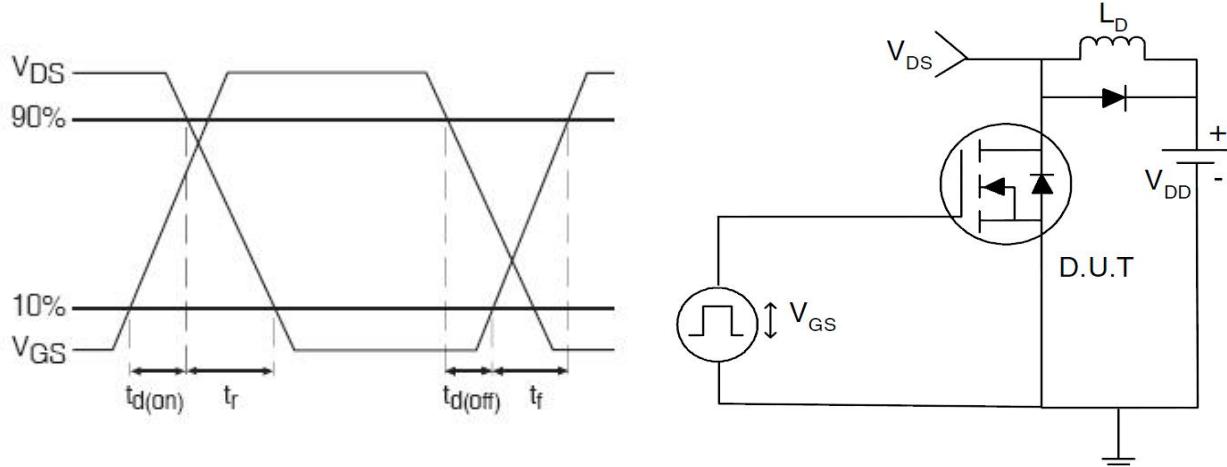
### 1) E<sub>AS</sub> Test Circuits



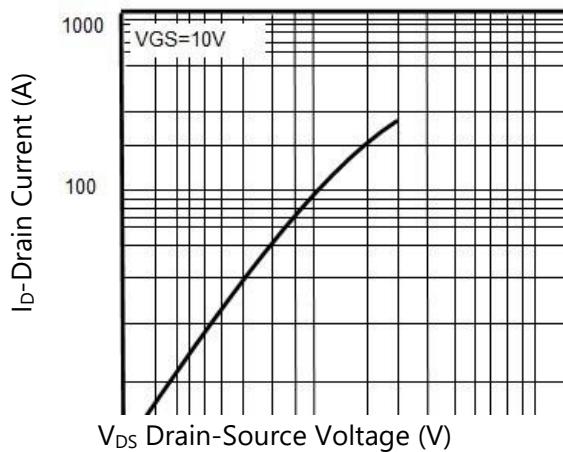
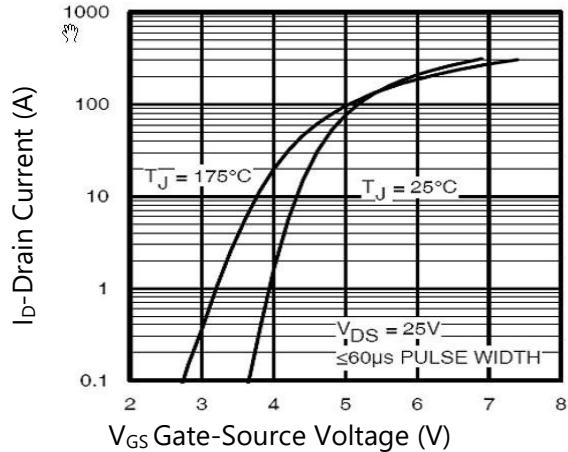
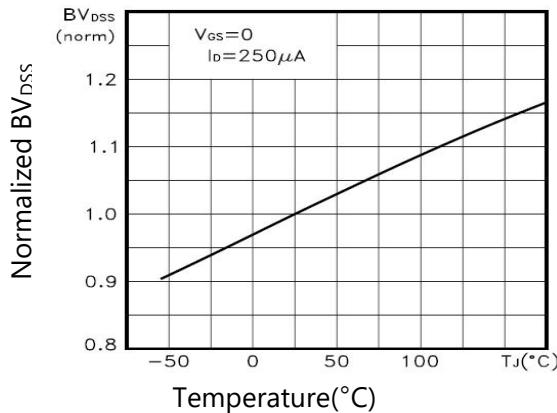
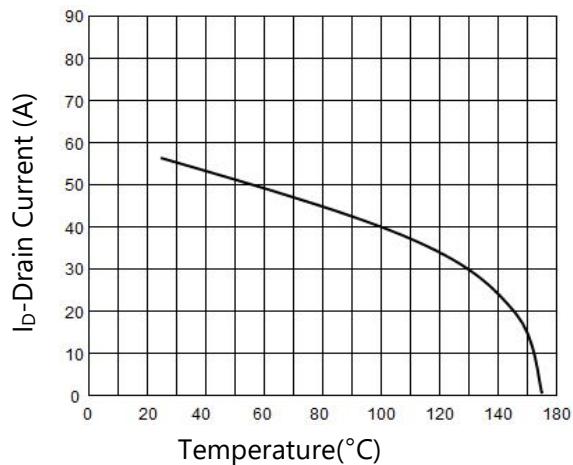
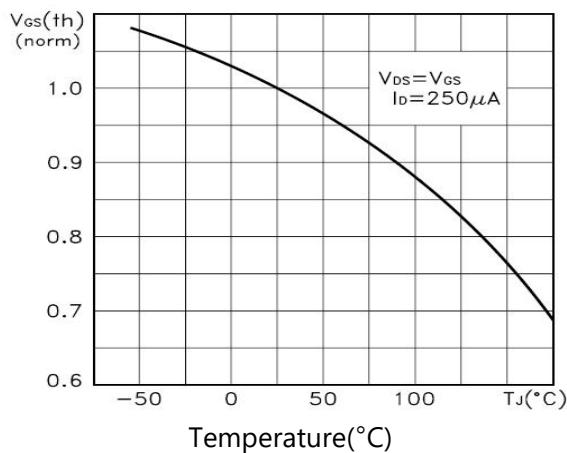
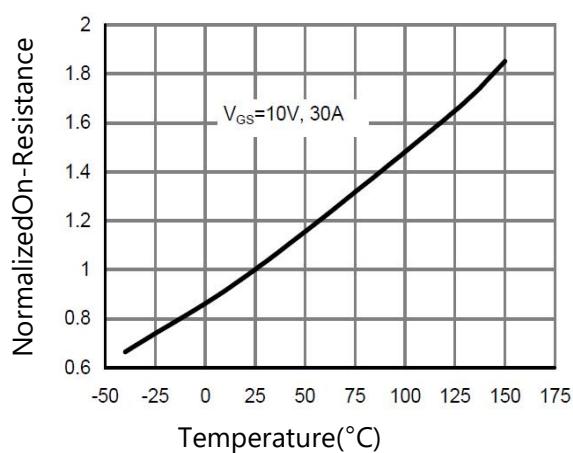
### 2) Gate Charge Test Circuit:



### 3) Switch Time Test Circuit:

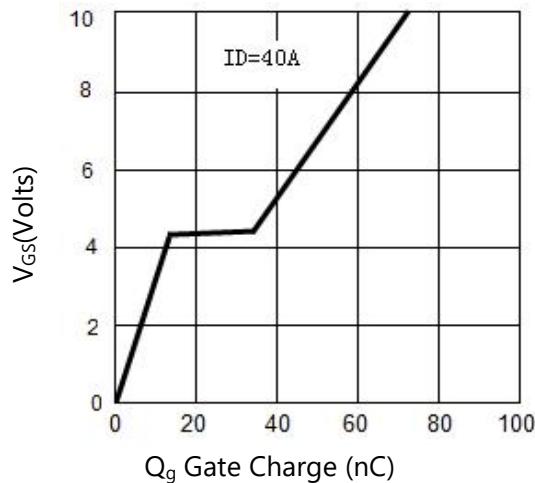


## TYPICAL PERFORMANCE CHARACTERISTICS

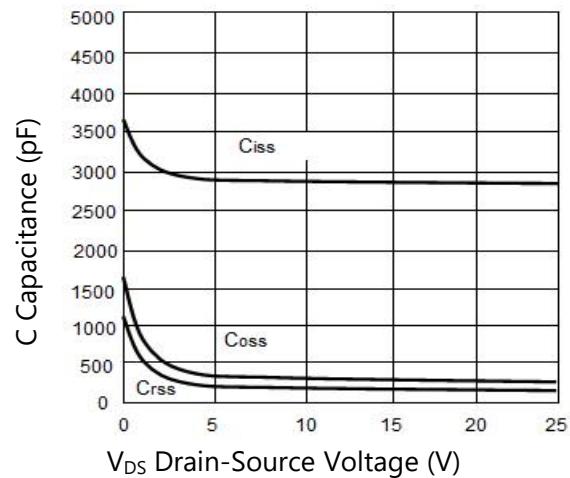
**Figure1. Output Characteristics**

**Figure2. Transfer Characteristics**

**Figure3.  $\text{BV}_{DSS}$  vs Junction Temperature**

**Figure4.  $I_D$  vs Junction Temperature**

**Figure5.  $V_{GS(\text{th})}$  vs Junction Temperature**

**Figure6.  $R_{dson}$  Vs Junction Temperature**


## TYPICAL PERFORMANCE CHARACTERISTICS

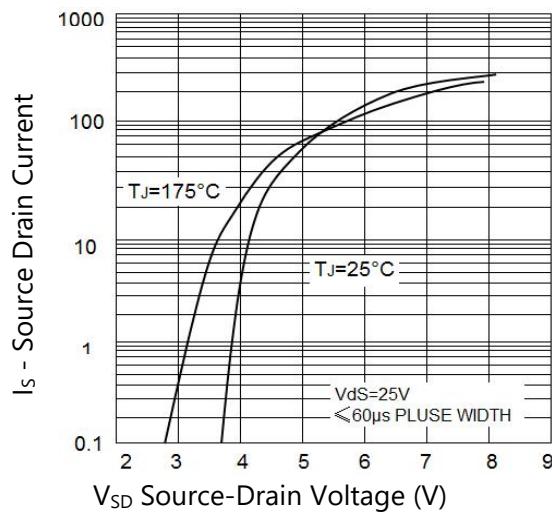
**Figure7. Gate Charge**



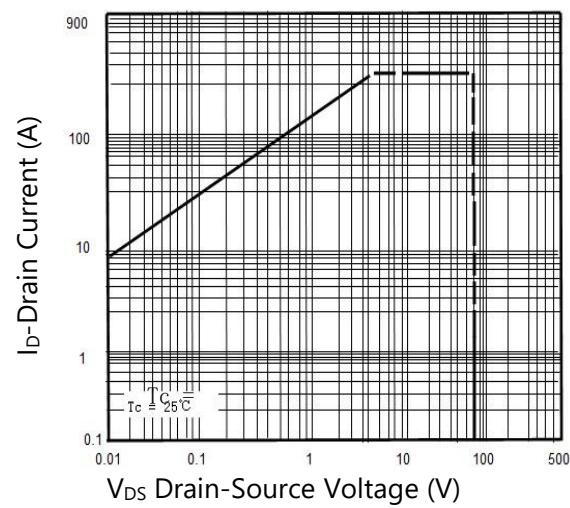
**Figure8. Capacitance vs V<sub>DS</sub>**



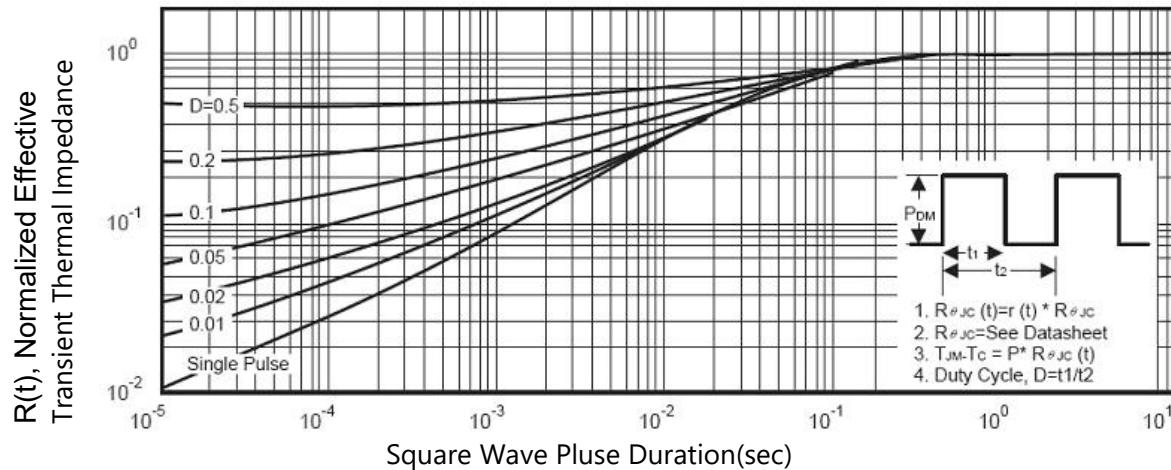
**Figure9. Source- Drain Diode Forward**

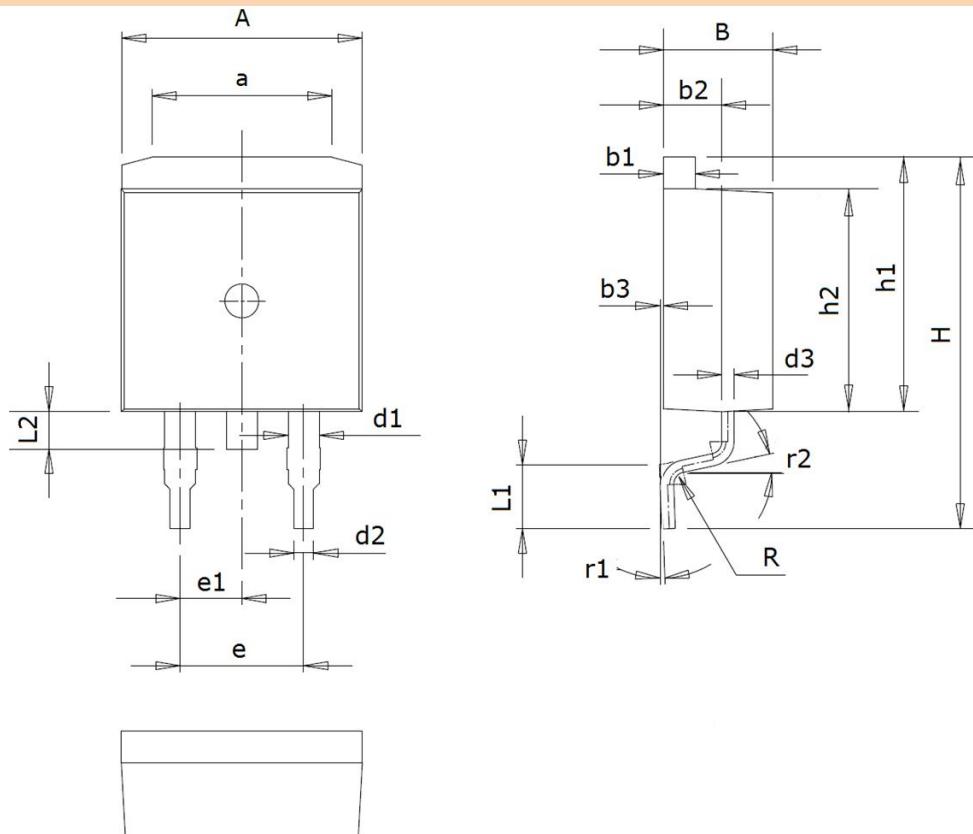


**Figure10. Safe Operation Area**



**Figure11. Normalized Maximum Transient Thermal Impedance**



**PACKAGE INFORMATION**
**TO-263**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	9.60	10.0	0.378	0.394
a	7.00	7.80	0.276	0.307
B	4.30	4.70	0.169	0.185
b1	1.25	1.35	0.049	0.053
b2	2.20	2.60	0.087	0.102
b3	0.00	0.20	0.000	0.008
d1	1.20	1.40	0.047	0.055
d2	0.70	0.90	0.028	0.035
d3	0.40	0.60	0.016	0.024
e	5.08(typ.)		0.200(typ.)	
e1	2.54(typ.)		0.100(typ.)	
H	15.20	15.80	0.598	0.622
h1	10.30	10.70	0.406	0.421
h2	9.10	9.40	0.358	0.370
L1	2.40	2.90	0.094	0.114
L2	1.30	1.80	0.051	0.071
R	0.5(typ.)		0.020(typ.)	
r1	0°	8°	0°	8°
r2	12°(typ.)		12°(typ.)	